

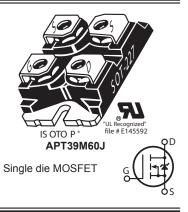


# APT39M60J

600V, 42A, 0.11Ω Max

## **N-Channel MOSFET**

Power MOS 8<sup>TM</sup> is a high speed, high voltage N-channel switch-mode power MOSFET. A proprietary planar stripe design yields excellent reliability and manufacturability. Low switching loss is achieved with low input capacitance and ultra low  $C_{rss}$  "Miller" capacitance. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control slew rates during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency. Reliability in flyback, boost, forward, and other circuits is enhanced by the high avalanche energy capability.



## **FEATURES**

- Fast switching with low EMI/RFI
- Low R<sub>DS(on)</sub>
- + Ultra low  $\mathbf{C}_{\mathrm{rss}}$  for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant

## **TYPICAL APPLICATIONS**

- PFC and other boost converter
- Buck converter
- Two switch forward (asymmetrical bridge)
- Single switch forward
- Flyback
- Inverters

### Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	42	
	Continuous Drain Current @ T <sub>C</sub> = 100°C	26	A
I <sub>DM</sub>	Pulsed Drain Current <sup>®</sup>	210	
V <sub>GS</sub>	Gate-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>©</sup>	1580	mJ
I <sub>AR</sub>	Avalanche Current, Repetitive or Non-Repetitive	28	А

## **Thermal and Mechanical Characteristics**

Symbol	Characteristic	Min	Тур	Max	Unit	
P <sub>D</sub>	Total Power Dissipation @ $T_{C}$ = 25°C			480	W	
R <sub>θJC</sub>	Junction to Case Thermal Resistance			0.26 °C/W		
$R_{ extsf{ heta}CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15			
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55		150	°C	
V <sub>Isolation</sub>	RMS Voltage (50-60hHz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)	2500			V	
W <sub>T</sub>	Package Weight		1.03		oz	
			29.2		g	
Torque	Terminale and Mounting Corours			10	in∙lbf	
	Terminals and Mounting Screws.			1.1	N∙m	

**Static Characteristics** 

## $T_1 = 25^{\circ}C$ unless otherwise specified

**APT39M60J** 

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
V <sub>BR(DSS)</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250 \mu A$	600			V
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I <sub>D</sub> = 250	μΑ	0.57		V/°C
R <sub>DS(on)</sub>	Drain-Source On Resistance <sup>③</sup>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 28A		0.09	0.11	Ω
V <sub>GS(th)</sub>	Gate-Source Threshold Voltage	(-1)	3	4	5	V
$\Delta V_{GS(th)} / \Delta T_J$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_{D} = 2.5 \text{mA}$		-10		mV/°C
	Zero Gate Voltage Drain Current	$V_{DS} = 600V$ $T_{J} = 25^{\circ}C$			100	μA
DSS		$V_{GS} = 0V$ $T_{J} = 125^{\circ}C$			500	μΛ
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = ±30V			±100	nA

#### **Dynamic Characteristics**

#### T<sub>J</sub> = 25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
9 <sub>fs</sub>	Forward Transconductance	$V_{DS} = 50V, I_{D} = 28A$		55		S
C <sub>iss</sub>	Input Capacitance	N/ 01/ 1/ 051/		11300		
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		115		
C <sub>oss</sub>	Output Capacitance			1040		
C <sub>o(cr)</sub> ⊕	Effective Output Capacitance, Charge Related	$V_{GS}$ = 0V, $V_{DS}$ = 0V to 400V		550		pF
C <sub>o(er)</sub> ⑤	Effective Output Capacitance, Energy Related			285		
Q <sub>g</sub>	Total Gate Charge			280		
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 0$ to 10V, $I_{D} = 28A$ ,		60		nC
$Q_{gd}$	Gate-Drain Charge	V <sub>DS</sub> = 300V		120		
t <sub>d(on)</sub>	Turn-On Delay Time	Resistive Switching		65		
t <sub>r</sub>	Current Rise Time	V <sub>DD</sub> = 400V, I <sub>D</sub> = 28A		75		
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{G} = 2.2 \Omega^{(0)}, V_{GG} = 15 V$		190		ns
t <sub>f</sub>	Current Fall Time	1		60		

## **Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
۱ <sub>s</sub>	Continuous Source Current (Body Diode)	MOSFET symbol showing the			42	•
I <sub>SM</sub>	Pulsed Source Current (Body Diode) <sup>①</sup>	integral reverse p-n junction diode (body diode)			210	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 28A, T <sub>J</sub> = 25°C, V <sub>GS</sub> = 0V			1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> = 28A <sup>③</sup>		745		ns
Q <sub>rr</sub>	Reverse Recovery Charge	di <sub>SD</sub> /dt = 100A/µs, T <sub>J</sub> = 25°C		19		μC
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 28A$ , di/dt $\le 1000A/\mu s$ , $V_{DD} = 100V$ , $T_{J} = 125^{\circ}C$			8	V/ns

- (1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- (2) Starting at  $T_J = 25^{\circ}C$ , L = 4.03mH,  $R_G = 25\Omega$ ,  $I_{AS} = 28A$ .
- (3) Pulse test: Pulse Width <  $380\mu$ s, duty cycle < 2%.
- (4) C<sub>o(cr)</sub> is defined as a fixed capacitance with the same stored charge as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>.
  (5) C<sub>o(er)</sub> is defined as a fixed capacitance with the same stored energy as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>. To calculate C<sub>o(er)</sub> for any value of V<sub>DS</sub> less than V<sub>(BR)DSS</sub>, use this equation: C<sub>o(er)</sub> = -1.10E-7/V<sub>DS</sub><sup>2</sup> + 4.60E-8/V<sub>DS</sub> + 1.72E-10.
- 6 R<sub>G</sub> is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

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